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Seong-Jun Song; Sung Min Park; Hoi-Jun Yoo;

Solid-State Circuits, IEEE Journal of , Volume: 38 , Issue: 7 , July 2003

Pages:1213 - 1219

[Abstract] [PDF Full-Text (573 KB)] **IEEE JNL**

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[PDF Full-Text (256 KB)] [Abstract]

3 Enhancing Interference Rejection of Preamplified Electrodes by **Automated Gain Adaption**

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4 A high-frequency thermal power comparator

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Pallas-Areny, R.; Webster, J.G.;

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[Abstract] [PDF Full-Text (148 KB)] **IEE CNF**

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